TEXAS INSTRUMENTS

SN74LV393B-EP エンハンスド製品、2V〜5.5V、低ノイズ、デュアル 4 ビット・バイナリ・カウンタ

1 特長

- 2V〜5.5V の V_{CC} で動作
- すべてのポートで混合モード電圧動作をサポート
- I_{off} により部分的パワーダウン・モードでの動作をサポート
- JESD 17 準拠で 250mA 超のラッチアップ性能
- 動作時周囲温度：-55℃〜+125℃
- 防衛、航空宇宙、医療アプリケーションをサポート：
  - 管理されたベースライン
  - 単一のアセンブリおよびテスト施設
  - 単一の製造施設
  - 長い製品ライフ・サイクル
  - 製品のトレーサビリティ

2 アプリケーション

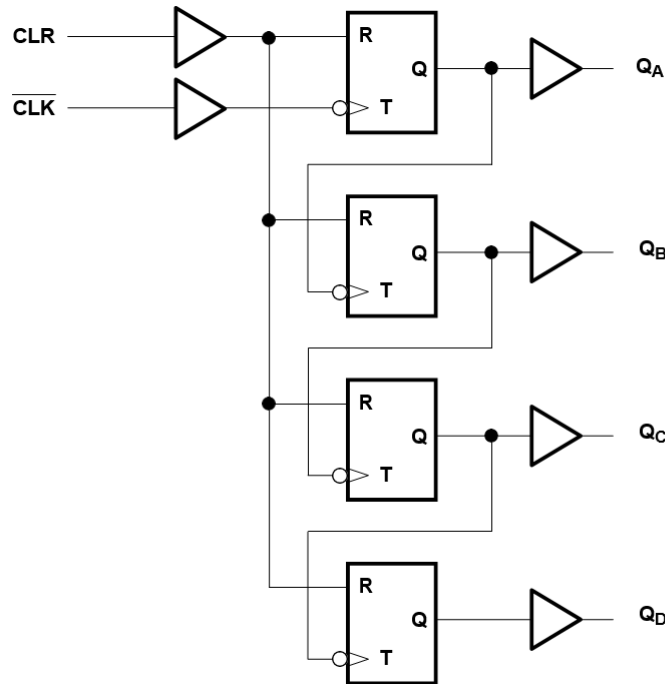- マイクロコントローラの入力数拡張
- システム・クロック拡張

3 概要

SN74LV393B-EP は 8 つのフリップ・フロップと追加のゲーティングを内蔵しており、2 つの独立した 4 ビット・カウンタを 1 つのパッケージに実装しており、2V〜5.5V の V_{CC} で動作するように設計されています。

このデバイスは、I_{off} を使った部分的パワーダウン・アプリケーション向けに完全に動作が規定されています。I_{off} 回路が出力をディセーブルにするため、電源切断時にデバイスに電流が逆流して損傷に至ることを回避できます。

パッケージ情報

部品番号	パッケージ [(1)]	パッケージ・サイズ [(2)]
SN74LV393B-EP	PW (TSSOP、14)	5mm × 6.4mm

(1) 利用可能なすべてのパッケージについては、データシートの末尾にある注文情報を参照してください。

(2) パッケージ・サイズ (長さ×幅) は公称値であり、該当する場合はピンも含まれます。

論理図 (正論理)

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4 Revision History

DATE	REVISION	NOTES
August 2023	*	Initial Release

5 Pin Configuration and Functions

図 5-1. SN74LV393B-EP: PW Package, 14-Pin TSSOP (Top View)

表 5-1. Pin Functions

PIN		TYPE[1]	DESCRIPTION
NAME	NO.		
1$\overline{\text{CLK}}$	1	I	Counter 1 Clock Input
1CLR	2	I	Counter 1 Clear Input
1Q$_A$	3	O	Counter 1 A Output
1Q$_B$	4	O	Counter 1 B Output
1Q$_C$	5	O	Counter 1 B Output
1Q$_D$	6	O	Counter 1 B Output
GND	7	G	Ground
2Q$_D$	8	O	Counter 2 D Output
2Q$_C$	9	O	Counter 2 C Output
2Q$_B$	10	O	Counter 2 B Output
2Q$_A$	11	O	Counter 2 A Output
2CLR	12	I	Counter 2 Clear Input
2$\overline{\text{CLK}}$	13	I	Counter 2 Clock Input
V$_{CC}$	14	P	Positive supply

(1)   I = Input, O = Output, I/O = Input or Output, G = Ground, P = Power.

6 Specifications

6.1 Absolute Maximum Ratings

Over operating free-air temperature range (unless otherwise noted)[1]

			MIN	MAX	UNIT
V_{CC}	Supply voltage		−0.5	7	V
V_I	Input voltage[2]		−0.5	7	V
V_O	Voltage range applied to any output in the high-impedance or power-off state[2]		−0.5	7	V
V_O	Output voltage [2] [3]		−0.5	V_{CC} + 0.5	V
I_{IK}	Input clamp current	$V_I < 0$		−20	mA
I_{OK}	Output clamp current	$V_O < 0$		−50	mA
I_O	Continuous output current	$V_O = 0$ to V_{CC}		±25	mA
	Continuous current through V_{CC} or GND			±50	mA
T_{stg}	Storage temperature		−65	150	°C

(1)   Operation outside the *Absolute Maximum Ratings* may cause permanent device damage. *Absolute Maximum Ratings* do not imply functional operation of the device at these or any other conditions beyond those listed under *Recommended Operating Conditions*. If used outside the *Recommended Operating Conditions* but within the *Absolute Maximum Ratings*, the device may not be fully functional, and this may affect device reliability, functionality, performance, and shorten the device lifetime.
(2)   The input and output negative-voltage ratings may be exceeded if the input and output current ratings are observed.
(3)   This value is limited to 5.5 V maximum.

6.2 ESD Ratings

			VALUE	UNIT
$V_{(ESD)}$	Electrostatic discharge	Human-body model (HBM), per ANSI/ESDA/JEDEC JS-001[1]	±2000	V
		Charged-device model (CDM), per ANSI/ESDA/JEDEC JS-002[2]	±1000	

(1)   JEDEC document JEP155 states that 500-V HBM allows safe manufacturing with a standard ESD control process.
(2)   JEDEC document JEP157 states that 250-V CDM allows safe manufacturing with a standard ESD control process

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: *SCLS948*

6.3 Recommended Operating Conditions

over operating free-air temperature range (unless otherwise noted)[1]

				MIN	MAX	UNIT
V_{CC}	Supply voltage			2	5.5	V
V_{IH}	High-level input voltage	V_{CC} = 2 V		1.5		V
		V_{CC} = 2.3 V to 5.5 V		V_{CC} × 0.7		
V_{IL}	Low-level input voltage	V_{CC} = 2 V			0.5	V
		V_{CC} = 2.3 V to 5.5 V			V_{CC} × 0.3	
V_I	Input voltage			0	5.5	V
V_O	Output voltage			0	V_{CC}	V
I_{OH}	High-level output current	V_{CC} = 2 V			−50	µA
		V_{CC} = 2.3 V to 2.7 V			−2	mA
		V_{CC} = 3 V to 3.6 V			−6	
		V_{CC} = 4.5 V to 5.5 V			−12	
I_{OL}	Low-level output current	V_{CC} = 2 V			50	µA
		V_{CC} = 2.3 V to 2.7 V			2	mA
		V_{CC} = 3 V to 3.6 V			6	
		V_{CC} = 4.5 V to 5.5 V			12	
Δt/Δv	Input transition rise or fall rate	V_{CC} = 2.3 V to 2.7 V			200	ns/V
		V_{CC} = 3 V to 3.6 V			100	
		V_{CC} = 4.5 V to 5.5 V			20	
T_A	Operating free-air temperature			−55	125	°C

(1)   All unused inputs of the device must be held at V_{CC} or GND for proper device operation. See *Implications of Slow or Floating CMOS Inputs.*

6.4 Thermal Information

THERMAL METRIC[1]		SN74LV393B-EP	UNIT
		PW (TSSOP)	
		16 PINS	
$R_{\theta JA}$	Junction-to-ambient thermal resistance	151	°C/W
$R_{\theta JC(top)}$	Junction-to-case (top) thermal resistance	80	°C/W
$R_{\theta JB}$	Junction-to-board thermal resistance	94.2	°C/W
ψ_{JT}	Junction-to-top characterization parameter	28	°C/W
ψ_{JB}	Junction-to-board characterization parameter	93.6	°C/W
$R_{\theta JC(bot)}$	Junction-to-case (bottom) thermal resistance	—	°C/W

(1)   For more information about traditional and new thermal metrics, see *Semiconductor and IC Package Thermal Metrics.*

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: *SCLS948*

6.5 Electrical Characteristics

over operating free-air temperature range (unless otherwise noted).

PARAMETER		V_{CC}	MIN	TYP	MAX	UNIT
V_{OH}	I_{OH} = –50 mA	2 V to 5.5 V	V_{CC} – 0.1			V
	I_{OH} = –2 mA	2.3 V	2			
	I_{OH} = –6 mA	3 V	2.48			
	I_{OH} = –12 mA	4.5 V	3.8			
V_{OL}	I_{OL} = 50 mA	2 V to 5.5 V			0.1	V
	I_{OL} = 2 mA	2.3 V			0.4	
	I_{OL} = 6 mA	3 V			0.44	
	I_{OL} = 12 mA	4.5 V			0.55	
I_I	V_I = 5.5 V or GND	0 V to 5.5 V			±1	µA
I_{CC}	V_I = V_{CC} or GND, I_O = 0	5.5 V			20	µA
I_{off}	V_I or V_O = 0 to 5.5 V	0 V			5	µA
C_i	V_I = V_{CC} or GND	3.3 V		1.8		pF

6.6 Timing Requirements, V_{CC} = 2.5 V ± 0.2 V

timing requirements over recommended operating free-air temperature range, V_{CC} = 2.5 V ± 0.2 V (unless otherwise noted)

			T_A = 25°C		-55ºC to 125ºC		UNIT
			MIN	MAX	MIN	MAX	
t_w	Pulse duration	$\overline{CLK}$ high or low	5		5		ns
		CLR high	5		5		
t_{su}	Setup time	CLR inactive before CLK ↓	6		6		ns

6.7 Timing Requirements, V_{CC} = 3.3 V ± 0.3 V

timing requirements over recommended operating free-air temperature range, V_{CC} = 3.3 V ± 0.3 V (unless otherwise noted)

			T_A = 25°C		-55ºC to 125ºC		UNIT
			MIN	MAX	MIN	MAX	
t_w	Pulse duration	$\overline{CLK}$ high or low	5		5		ns
		CLR high	5		5		
t_{su}	Setup time	CLR inactive before CLK ↓	5		5		ns

6.8 Timing Requirements, V_{CC} = 5 V ± 0.5 V

timing requirements over recommended operating free-air temperature range, V_{CC} = 5 V ± 0.5 V (unless otherwise noted)

			T_A = 25°C		-55ºC to 125ºC		UNIT
			MIN	MAX	MIN	MAX	
t_w	Pulse duration	$\overline{CLK}$ high or low	5		5		ns
		CLR high	5		5		
t_{su}	Setup time	CLR inactive before CLK ↓	4		4		ns

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: *SCLS948*

6.9 Switching Characteristics, V$_{CC}$ = 2.5 V ± 0.2 V

over operating free-air temperature range, V$_{CC}$ = 2.5 V ± 0.2 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	TA = 25°C			-55°C to 125°C		UNIT
				MIN	TYP	MAX	MIN	MAX	
f$_{max}$			C$_L$ = 50 pF	30	70		25		MHz
t$_{pd}$	$\overline{CLK}$	Q$_A$	C$_L$ = 50 pF		9.3	21.3	1	24.5	ns
		Q$_B$			10.9	23.9	1	27.5	
		Q$_C$			12.3	26.1	1	30	
		Q$_D$			13.4	27.8	1	32	
t$_{PHL}$	CLR	Q$_n$			9.1	17.4	1	20	

6.10 Switching Characteristics, V$_{CC}$ = 3.3 V ± 0.3 V

over operating free-air temperature range, V$_{CC}$ = 3.3 V ± 0.3 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	TA = 25°C			-55°C to 125°C		UNIT
				MIN	TYP	MAX	MIN	MAX	
f$_{max}$			C$_L$ = 50 pF	45	105		35		MHz
t$_{pd}$	$\overline{CLK}$	Q$_A$	C$_L$ = 50 pF		6.7	16.7	1	19	ns
		Q$_B$			7.8	19.3	1	22	
		Q$_C$			8.7	21.5	1	24.5	
		Q$_D$			9.5	23.2	1	26.5	
t$_{PHL}$	CLR	Q$_n$			6.8	15.8	1	18	

6.11 Switching Characteristics, V$_{CC}$ = 5 V ± 0.5 V

over operating free-air temperature range, V$_{CC}$ = 5 V ± 0.5 V (unless otherwise noted)

PARAMETER	FROM (INPUT)	TO (OUTPUT)	TEST CONDITIONS	TA = 25°C			-55°C to 125°C		UNIT
				MIN	TYP	MAX	MIN	MAX	
f$_{max}$			C$_L$ = 50 pF	85	150		75		MHz
t$_{pd}$	$\overline{CLK}$	Q$_A$	C$_L$ = 50 pF		4.9	10.5	1	12	ns
		Q$_B$			5.6	11.8	1	13.5	
		Q$_C$			6.2	13.2	1	15	
		Q$_D$			6.6	14.5	1	16.5	
t$_{PHL}$	CLR	Q$_n$			5.2	10.1	1	11.5	

6.12 Noise Characteristics

V$_{CC}$ = 3.3 V, C$_L$ = 50 pF, T$_A$ = 25°C

PARAMETER[1]		SN74LV393A			UNIT
		MIN	TYP	MAX	
V$_{OL(P)}$	Quiet output, maximum dynamic V$_{OL}$		0.3	0.8	V
V$_{OL(V)}$	Quiet output, minimum dynamic V$_{OL}$		− 0.2	−0.8	V
V$_{OH(V)}$	Quiet output, minimum dynamic V$_{OH}$		2.8		V
V$_{IH(D)}$	High-level dynamic input voltage	2.31			V
V$_{IL(D)}$	Low-level dynamic input voltage			0.99	V

(1)   Characteristics for surface-mount packages only.

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6.13 Operating Characteristics

T_A = 25°C

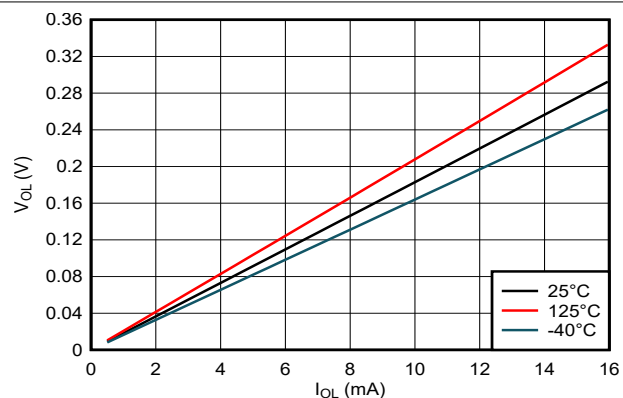| PARAMETER		TEST CONDITIONS	V_{CC}	TYP	UNIT
C_{pd}	Power dissipation capacitance	C_L = 50 pF f = 10 MHz	3.3 V	36.1	pF
			5 V	37.5	

6.14 Typical Characteristics

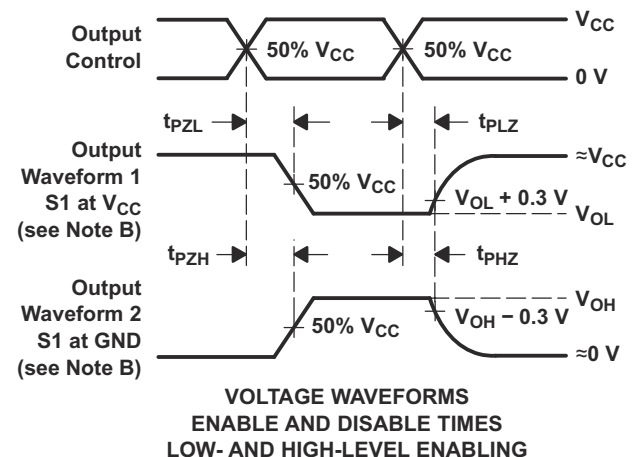図 **6-1. Output Voltage vs Current in LOW State; 5-V Supply**

図 **6-2. Output Voltage vs Current in HIGH State; 5-V Supply**

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: *SCLS948*

7 Parameter Measurement Information

TEST	S1
t_{PLH}/t_{PHL}	Open
t_{PLZ}/t_{PZL}	V_{CC}
t_{PHZ}/t_{PZH}	GND
Open Drain	V_{CC}

LOAD CIRCUIT FOR TOTEM-POLE OUTPUTS

LOAD CIRCUIT FOR 3-STATE AND OPEN-DRAIN OUTPUTS

VOLTAGE WAVEFORMS PULSE DURATION

VOLTAGE WAVEFORMS SETUP AND HOLD TIMES

VOLTAGE WAVEFORMS PROPAGATION DELAY TIMES INVERTING AND NONINVERTING OUTPUTS

VOLTAGE WAVEFORMS ENABLE AND DISABLE TIMES LOW- AND HIGH-LEVEL ENABLING

A. C_L includes probe and jig capacitance.
B. Waveform 1 is for an output with internal conditions such that the output is low, except when disabled by the output control.
    Waveform 2 is for an output with internal conditions such that the output is high, except when disabled by the output control.
C. All input pulses are supplied by generators having the following characteristics: PRR ≤ 1 MHz, Z_O = 50 Ω, t_r ≤ 3 ns, and t_f ≤ 3 ns.
D. The outputs are measured one at a time, with one input transition per measurement.
E. t_{PLZ} and t_{PHZ} are the same as t_{dis}.
F. t_{PZL} and t_{PZH} are the same as t_{en}.
G. t_{PHL} and t_{PLH} are the same as t_{pd}.
H. All parameters and waveforms are not applicable to all devices.
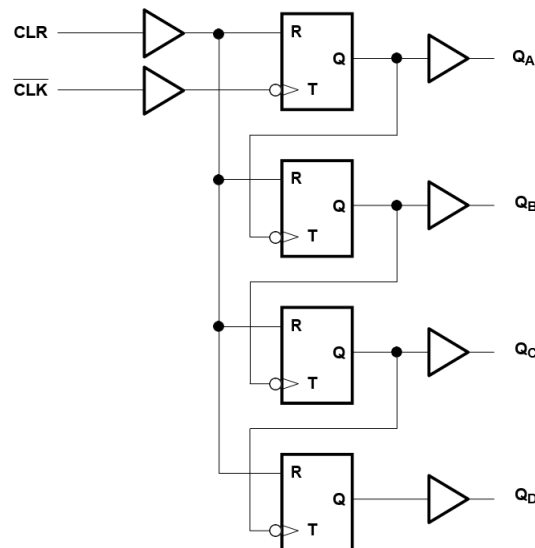
図 7-1. Load Circuit and Voltage Waveforms

8 Detailed Description

8.1 Overview

The SN74LV393B-EP contains two independent 4-bit binary counters, each having a clear (CLR) and a clock ($\overline{\text{CLK}}$) input. These devices change state on the negative-going transition of the $\overline{\text{CLK}}$ pulse. N-bit binary counters can be implemented with each package, providing the capability of divide by 256. The SN74LV393B-EP has parallel outputs from each counter stage so that any sub multiple of the input count frequency is available for system timing signals.

This device is fully specified for partial-power-down applications using I_{off}. The I_{off} circuitry disables the outputs, preventing damaging current backflow through the device when powered down.

8.2 Functional Block Diagram

8.3 Feature Description

8.3.1 Balanced CMOS Push-Pull Outputs

This device includes balanced CMOS push-pull outputs. The term *balanced* indicates that the device can sink and source similar currents. The drive capability of this device may create fast edges into light loads, so routing and load conditions should be considered to prevent ringing. Additionally, the outputs of this device are capable of driving larger currents than the device can sustain without being damaged. It is important for the output power of the device to be limited to avoid damage due to overcurrent. The electrical and thermal limits defined in the *Absolute Maximum Ratings* must be followed at all times.

Unused push-pull CMOS outputs should be left disconnected.

8.3.2 Latching Logic

This device includes latching logic circuitry. Latching circuits commonly include D-type latches and D-type flip-flops, but include all logic circuits that act as volatile memory.

When the device is powered on, the state of each latch is unknown. There is no default state for each latch at start-up.

The output state of each latching logic circuit only remains stable as long as power is applied to the device within the supply voltage range specified in the *Recommended Operating Conditions* table.

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: *SCLS948*

8.3.3 Partial Power Down (I_{off})

This device includes circuitry to disable all outputs when the supply pin is held at 0 V. When disabled, the outputs will neither source nor sink current, regardless of the input voltages applied. The amount of leakage current at each output is defined by the I_{off} specification in the *Electrical Characteristics* table.

8.3.4 Clamp Diode Structure

図 8-1 shows the inputs and outputs to this device have negative clamping diodes only.

> **注意**
> Voltages beyond the values specified in the *Absolute Maximum Ratings* table can cause damage to the device. The input and output voltage ratings may be exceeded if the input and output clamp-current ratings are observed.
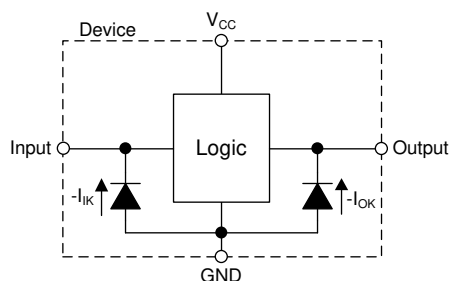
図 8-1. Electrical Placement of Clamping Diodes for Each Input and Output

8.4 Device Functional Modes

表 8-1 lists the functional modes of the SN74LV393B-EP.

表 8-1. Operating Mode Table

INPUTS		FUNCTION[1]
$\overline{\text{CLK}}$	CLR	
↑	L	No change
↓	L	Advance to next stage
X	H	All outputs L

(1) H = High Voltage Level, L = Low Voltage Level, X = Do Not Care, ↑ = Low to High transition

Product Folder Links: *SN74LV393B-EP*

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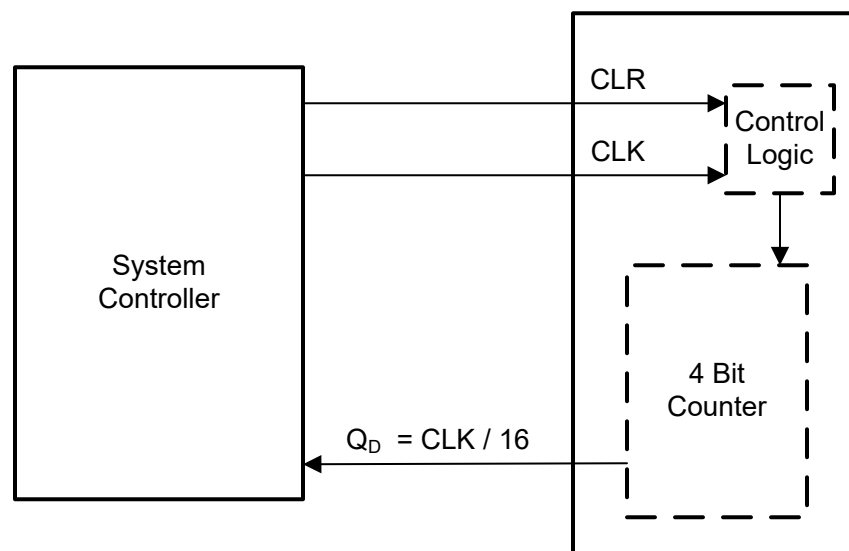# 9 Application and Implementation

注

Information in the following applications sections is not part of the TI component specification, and TI does not warrant its accuracy or completeness. TI's customers are responsible for determining suitability of components for their purposes, as well as validating and testing their design implementation to confirm system functionality.

9.1 Application Information

The SN74LV393B-EP is a dual 4-bit binary counter that can be used to create extended clock systems for controllers. Using a single CLK input and CLR signal, the device can output multiples of 2. Both counter banks can also be combined to divide the CLK signal by a factor of 256.

9.2 Typical Application

図 9-1. System Clock Divider

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Product Folder Links: *SN74LV393B-EP*

English Data Sheet: SCLS948

9.2.1 Power Considerations

Ensure the desired supply voltage is within the range specified in the *Recommended Operating Conditions*. The supply voltage sets the device's electrical characteristics as described in the *Electrical Characteristics* section.

The positive voltage supply must be capable of sourcing current equal to the total current to be sourced by all outputs of the SN74LV393B-EP plus the maximum static supply current, I_{CC}, listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only source as much current that is provided by the positive supply source. Be sure to not exceed the maximum total current through V_{CC} listed in the *Absolute Maximum Ratings*.

The ground must be capable of sinking current equal to the total current to be sunk by all outputs of the SN74LV393B-EP plus the maximum supply current, I_{CC}, listed in the *Electrical Characteristics*, and any transient current required for switching. The logic device can only sink as much current that can be sunk into its ground connection. Be sure to not exceed the maximum total current through GND listed in the *Absolute Maximum Ratings*.

The SN74LV393B-EP can drive a load with a total capacitance less than or equal to 50 pF while still meeting all of the data sheet specifications. Larger capacitive loads can be applied; however, it is not recommended to exceed 50 pF.

The SN74LV393B-EP can drive a load with total resistance described by $R_L \geq V_O / I_O$, with the output voltage and current defined in the *Electrical Characteristics* table with V_{OH} and V_{OL}. When outputting in the HIGH state, the output voltage in the equation is defined as the difference between the measured output voltage and the supply voltage at the V_{CC} pin.

Total power consumption can be calculated using the information provided in *CMOS Power Consumption and Cpd Calculation*.

Thermal increase can be calculated using the information provided in *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices*.

> 注意
> The maximum junction temperature, $T_{J(max)}$ listed in the *Absolute Maximum Ratings*, is an additional limitation to prevent damage to the device. Do not violate any values listed in the *Absolute Maximum Ratings*. These limits are provided to prevent damage to the device.

9.2.2 Input Considerations

Input signals must cross $V_{IL(max)}$ to be considered a logic LOW, and $V_{IH(min)}$ to be considered a logic HIGH. Do not exceed the maximum input voltage range found in the *Absolute Maximum Ratings*.

Unused inputs must be terminated to either V_{CC} or ground. The unused inputs can be directly terminated if the input is completely unused, or they can be connected with a pull-up or pull-down resistor if the input will be used sometimes, but not always. A pull-up resistor is used for a default state of HIGH, and a pull-down resistor is used for a default state of LOW. The drive current of the controller, leakage current into the SN74LV393B-EP (as specified in the *Electrical Characteristics*), and the desired input transition rate limits the resistor size. A 10-kΩ resistor value is often used due to these factors.

The SN74LV393B-EP has CMOS inputs and thus requires fast input transitions to operate correctly, as defined in the *Recommended Operating Conditions* table. Slow input transitions can cause oscillations, additional power consumption, and reduction in device reliability.

Refer to the *Feature Description* section for additional information regarding the inputs for this device.

9.2.3 Output Considerations

The positive supply voltage is used to produce the output HIGH voltage. Drawing current from the output will decrease the output voltage as specified by the V_{OH} specification in the *Electrical Characteristics*. The ground voltage is used to produce the output LOW voltage. Sinking current into the output will increase the output voltage as specified by the V_{OL} specification in the *Electrical Characteristics*.

Push-pull outputs that could be in opposite states, even for a very short time period, should never be connected directly together. This can cause excessive current and damage to the device.

Two channels within the same device with the same input signals can be connected in parallel for additional output drive strength.
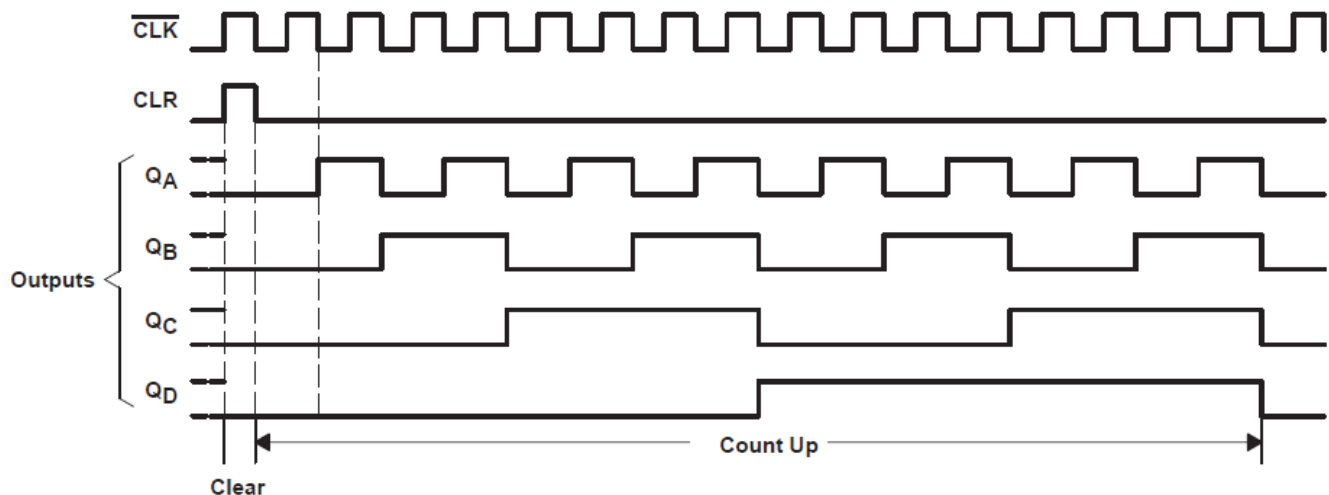
Unused outputs can be left floating. Do not connect outputs directly to V_{CC} or ground.

Refer to the *Feature Description* section for additional information regarding the outputs for this device.

9.2.4 Detailed Design Procedure

1. Add a decoupling capacitor from V_{CC} to GND. The capacitor needs to be placed physically close to the device and electrically close to both the V_{CC} and GND pins. An example layout is shown in the *Layout* section.
2. Ensure the capacitive load at the output is ≤ 50 pF. This is not a hard limit; it will, however, optimize performance. This can be accomplished by providing short, appropriately sized traces from the SN74LV393B-EP to one or more of the receiving devices.
3. Ensure the resistive load at the output is larger than (V_{CC} / $I_{O(max)}$) Ω, which will not violate the maximum output current from the *Absolute Maximum Ratings*. Most CMOS inputs have a resistive load measured in MΩ; much larger than the minimum calculated previously.
4. Thermal issues are rarely a concern for logic gates; the power consumption and thermal increase, however, can be calculated using the steps provided in the application report, *CMOS Power Consumption and Cpd Calculation*.

9.2.5 Application Curves

図 9-2. Application Timing Diagram

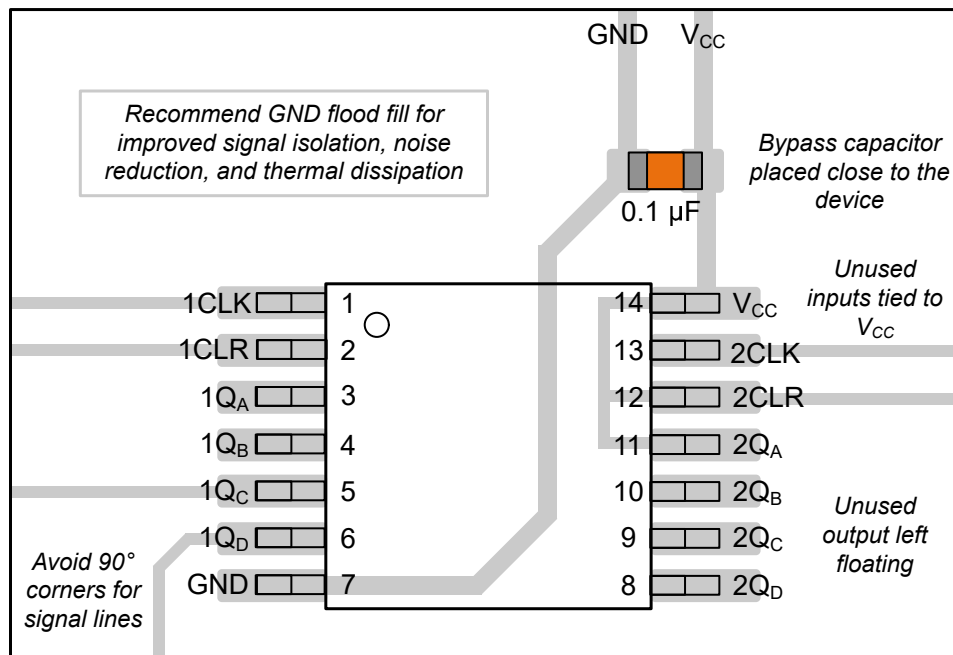## 9.3 Power Supply Recommendations

The power supply can be any voltage between the minimum and maximum supply voltage rating located in the *Absolute Maximum Ratings* section. Each V_{CC} terminal must have a good bypass capacitor to prevent power disturbance. For devices with a single supply, TI recommends a 0.1-µF capacitor; if there are multiple V_{CC} terminals, then TI recommends a 0.01-µF or 0.022-µF capacitor for each power terminal. Multiple bypass capacitors can be paralleled to reject different frequencies of noise. Frequencies of 0.1 µF and 1 µF are commonly used in parallel. The bypass capacitor must be installed as close as possible to the power terminal for best results.

9.4 Layout

9.4.1 Layout Guidelines

When using multiple bit logic devices, inputs should not float. In many cases, functions or parts of functions of digital logic devices are unused. Some examples are when only two inputs of a triple-input AND gate are used, or when only 3 of the 4-buffer gates are used. Such unused input pins must not be left unconnected because the undefined voltages at the outside connections result in undefined operational states. All unused inputs of digital logic devices must be connected to a logic high or logic low voltage, as defined by the input voltage specifications, to prevent them from floating. The logic level that must be applied to any particular unused input depends on the function of the device. Generally, the inputs are tied to GND or V_{CC}, whichever makes more sense for the logic function or is more convenient.

9.4.2 Layout Example

図 9-3. Layout Example for the SN74LV393B-EP in the PW Package

Product Folder Links: *SN74LV393B-EP*

English Data Sheet: SCLS948

10 Device and Documentation Support

10.1 Documentation Support

10.1.1 Related Documentation

For related documentation, see the following:

• Texas Instruments, *CMOS Power Consumption and Cpd Calculation*
• Texas Instruments, *Power-Up Behavior of Clocked Devices*
• Texas Instruments, *Introduction to Logic*
• Texas Instruments, *Thermal Characteristics of Standard Linear and Logic (SLL) Packages and Devices*

10.2 Receiving Notification of Documentation Updates

To receive notification of documentation updates—including silicon errata—go to the product folder for your device on ti.com. In the upper right-hand corner, click the *Alert me* button. This registers you to receive a weekly digest of product information that has changed (if any). For change details, check the revision history of any revised document.

10.3 サポート・リソース

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10.4 Trademarks

TI E2E™ is a trademark of Texas Instruments.
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10.5 静電気放電に関する注意事項

この IC は、ESD によって破損する可能性があります。テキサス・インスツルメンツは、IC を取り扱う際には常に適切な注意を払うことを推奨します。正しい取り扱いおよび設置手順に従わない場合、デバイスを破損するおそれがあります。

ESD による破損は、わずかな性能低下からデバイスの完全な故障まで多岐にわたります。精密な IC の場合、パラメータがわずかに変化するだけで公表されている仕様から外れる可能性があるため、破損が発生しやすくなっています。

10.6 用語集

テキサス・インスツルメンツ用語集　　　この用語集には、用語や略語の一覧および定義が記載されています。

11 Mechanical, Packaging, and Orderable Information

The following pages include mechanical, packaging, and orderable information. This information is the most current data available for the designated devices. This data is subject to change without notice and revision of this document. For browser-based versions of this data sheet, refer to the left-hand navigation.

PACKAGING INFORMATION

Orderable Device	Status (1)	Package Type	Package Drawing	Pins	Package Qty	Eco Plan (2)	Lead finish/ Ball material (6)	MSL Peak Temp (3)	Op Temp (°C)	Device Marking (4/5)	Samples
SN74LV393BMPWREP	ACTIVE	TSSOP	PW	14	3000	RoHS & Green	NIPDAU	Level-1-260C-UNLIM	-55 to 125	LV393EP	Samples
V62/23624-01XE	ACTIVE	TSSOP	PW	14	3000	TBD	Call TI	Call TI			Samples

(1) The marketing status values are defined as follows:
ACTIVE: Product device recommended for new designs.
LIFEBUY: TI has announced that the device will be discontinued, and a lifetime-buy period is in effect.
NRND: Not recommended for new designs. Device is in production to support existing customers, but TI does not recommend using this part in a new design.
PREVIEW: Device has been announced but is not in production. Samples may or may not be available.
OBSOLETE: TI has discontinued the production of the device.

(2) **RoHS:** TI defines "RoHS" to mean semiconductor products that are compliant with the current EU RoHS requirements for all 10 RoHS substances, including the requirement that RoHS substance do not exceed 0.1% by weight in homogeneous materials. Where designed to be soldered at high temperatures, "RoHS" products are suitable for use in specified lead-free processes. TI may reference these types of products as "Pb-Free".
RoHS Exempt: TI defines "RoHS Exempt" to mean products that contain lead but are compliant with EU RoHS pursuant to a specific EU RoHS exemption.
Green: TI defines "Green" to mean the content of Chlorine (Cl) and Bromine (Br) based flame retardants meet JS709B low halogen requirements of <=1000ppm threshold. Antimony trioxide based flame retardants must also meet the <=1000ppm threshold requirement.

(3) MSL, Peak Temp. - The Moisture Sensitivity Level rating according to the JEDEC industry standard classifications, and peak solder temperature.

(4) There may be additional marking, which relates to the logo, the lot trace code information, or the environmental category on the device.

(5) Multiple Device Markings will be inside parentheses. Only one Device Marking contained in parentheses and separated by a "~" will appear on a device. If a line is indented then it is a continuation of the previous line and the two combined represent the entire Device Marking for that device.

(6) Lead finish/Ball material - Orderable Devices may have multiple material finish options. Finish options are separated by a vertical ruled line. Lead finish/Ball material values may wrap to two lines if the finish value exceeds the maximum column width.

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In no event shall TI's liability arising out of such information exceed the total purchase price of the TI part(s) at issue in this document sold by TI to Customer on an annual basis.

PW (R−PDSO−G14)   PLASTIC SMALL OUTLINE

0,65 |→| |←   0,30 / 0,19 |⊕| 0,10 Ⓜ|

14

8

⟨D⟩   4,50 / 4,30   6,60 / 6,20

1   7

5,10 / 4,90

⟨C⟩

0,15 NOM

Gage Plane

0°−8°   0,25

0,75 / 0,50

1,20 MAX   0,15 / 0,05

Seating Plane

|◠| 0,10|

4040064−3/G 02/11

NOTES: A.   All linear dimensions are in millimeters. Dimensioning and tolerancing per ASME Y14.5M−1994.
          B.   This drawing is subject to change without notice.
          ⟨C⟩   Body length does not include mold flash, protrusions, or gate burrs. Mold flash, protrusions, or gate burrs shall
                not exceed 0,15 each side.
          ⟨D⟩   Body width does not include interlead flash. Interlead flash shall not exceed 0,25 each side.
          E.   Falls within JEDEC MO−153